

ROHS COMPLIANT HALOGEN

FREE

## 3401 CMN3401-VB Datasheet

## P-Channel 30 V (D-S) MOSFET

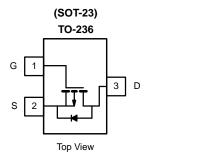
PRODUCT SUMMARY							
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Typ.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)				
	0.046 at V <sub>GS</sub> = - 10 V	- 5.6					
- 30	0.049 at V <sub>GS</sub> = - 6 V	- 5	11.4 nC				
	0.054 at V <sub>GS</sub> = - 4.5 V	-4.5					

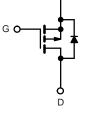


- TrenchFET<sup>®</sup> Power MOSFET
  100 % R<sub>g</sub> Tested
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#### **APPLICATIONS**

- For Mobile Computing
  - Load Switch
  - Notebook Adaptor Switch
  - DC/DC Converter





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P-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	<b>IGS</b> (T <sub>A</sub> = 25 °C	, unless otherw	vise noted)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	- 30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
	T <sub>C</sub> = 25 °C		- 5.6	
Constitutions Desire Constants (T. 450 °C)	T <sub>C</sub> = 70 °C		- 5.1	
Continuous Drain Current ( $T_J = 150 \ ^{\circ}C$ )	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 5.4 <sup>b,c</sup>	
	T <sub>A</sub> = 70 °C		- 4.3 <sup>b,c</sup>	A
Pulsed Drain Current (t = 100 µs)		I <sub>DM</sub>	- 18	
Continuus Courses Drain Diada Current	T <sub>C</sub> = 25 °C		- 2.1	
Continous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub> —	- 1 <sup>b,c</sup>	
	T <sub>C</sub> = 25 °C		2.5	
Maximum Davias Disaination	T <sub>C</sub> = 70 °C		1.6	14/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub> —	1.25 <sup>b,c</sup>	W
	T <sub>A</sub> = 70 °C	1 -	0.8 <sup>b,c</sup>	
Operating Junction and Storage Temperatur	T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C	

#### THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b,d</sup>	$t \le 5 s$	R <sub>thJA</sub>	75	100	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	40	50	0/11		

Notes:

a. Based on T<sub>C</sub> = 25 °C.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 166 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				•			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = -250 \mu A$	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L _ 250 uA		- 19		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	l <sub>D</sub> = - 250 μΑ		4			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = -250 \ \mu A$	- 0.5		- 2.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
		V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V			- 1	μA	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 5		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 V$ , $V_{GS} = -10 V$	- 2.5			Α	
		V <sub>GS</sub> =- 10 V, I <sub>D</sub> = - 4.4 A		0.046			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> =- 6 V, I <sub>D</sub> = - 4 A		0.049		Ω	
		V <sub>GS</sub> =- 4.5 V, I <sub>D</sub> = - 3.6 A		0.054			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 3.4 A		18		S	
Dynamic <sup>b</sup>				Į	Į	<b>ب</b>	
Input Capacitance	C <sub>iss</sub>			1295			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		150		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			130			
Total Gate Charge	Qg	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 5.4 A		24	36	_	
				11.4	17	-	
Gate-Source Charge Q <sub>gs</sub>		V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 5.4 A		3.4		nC	
Gate-Drain Charge	Q <sub>gd</sub>			3.8		-	
Gate Resistance	R <sub>g</sub>	f = 1 MHz	1.5	7.7	15.4	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			13	20		
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = - 15 V, R <sub>I</sub> = 3.5 Ω		4	8	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 4.3 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		38	57		
Fall Time	t <sub>f</sub>			6	12		
Turn-On Delay Time	t <sub>d(on)</sub>			28	42	ns	
Rise Time t <sub>r</sub>		V <sub>DD</sub> = - 15 V, R <sub>I</sub> = 3.5 Ω		16	24	1	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 4.3 A, $V_{GEN}$ = - 4.5 V, $R_q$ = 1 $\Omega$		30	45		
Fall Time	t <sub>f</sub>	Ť		10	20		
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current		T <sub>C</sub> = 25 °C			- 2.1		
Pulse Diode Forward Current (t = $100 \mu s$ )	I <sub>SM</sub>				- 80	- A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 4.3 A, V <sub>GS</sub> = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			15	23	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			7	14	nC	
Reverse Recovery Fall Time	ta	I <sub>F</sub> = - 4.3 A, dl/dt = 100 A/µs, T <sub>J</sub> = 25 °C		8			
Reverse Recovery Rise Time	t <sub>b</sub>	1 F		7	<u> </u>	ns	

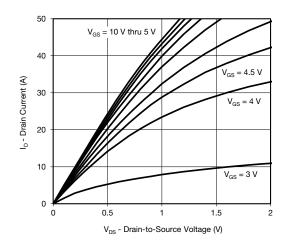
Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

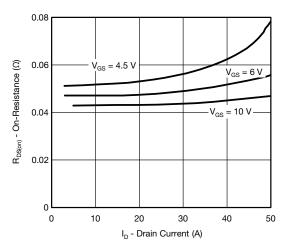
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

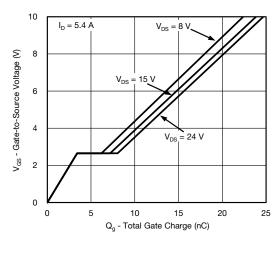




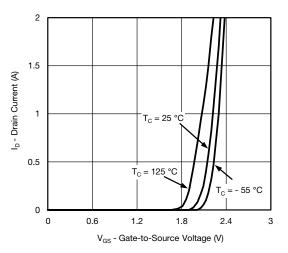




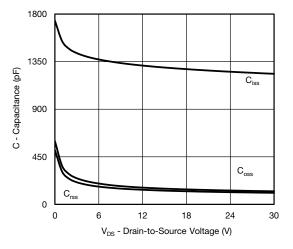
**On-Resistance vs. Drain Current** 



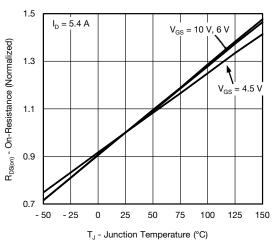
**Gate Charge** 



**Transfer Characteristics** 

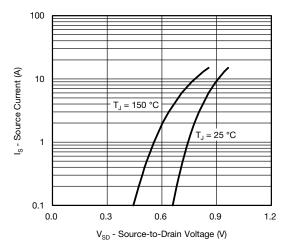






**On-Resistance vs. Junction Temperature** 

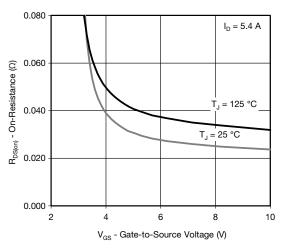




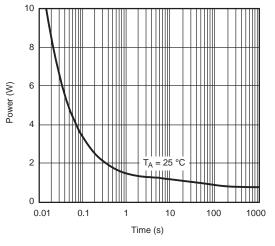




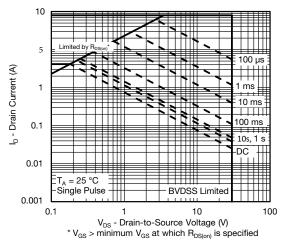
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

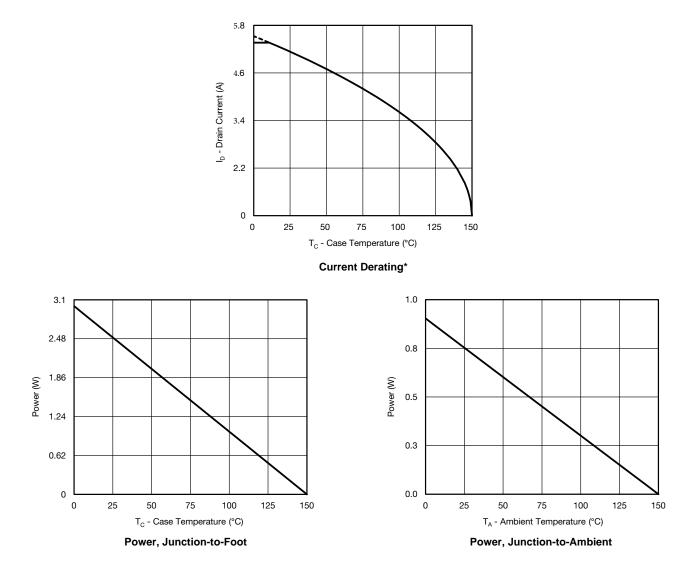


Single Pulse Power (Junction-to-Ambient)



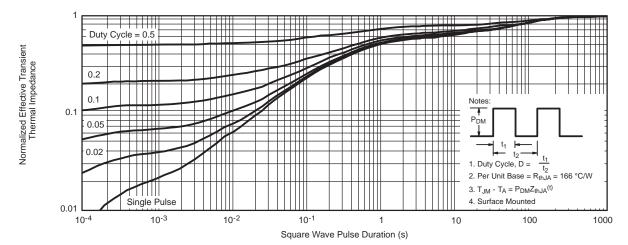
Safe Operating Area, Junction-to-Ambient



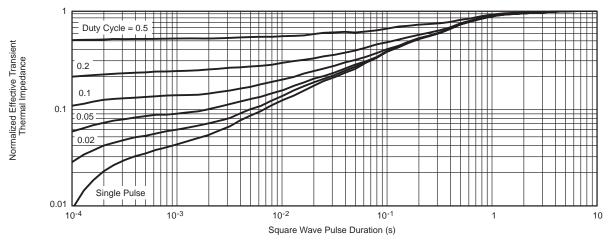


\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

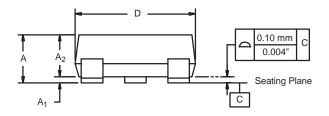


Normalized Thermal Transient Impedance, Junction-to-Foot



## SOT-23 (TO-236): 3-LEAD







Dim	MILLIN	METERS	INCHES			
	Min	Max	Min	Max		
Α	0.89	1.12	0.035	0.044		
A <sub>1</sub>	0.01	0.10	0.0004	0.004		
A <sub>2</sub>	0.88	1.02	0.0346	0.040		
b	0.35	0.50	0.014	0.020		
C	0.085	0.18	0.003	0.007		
D	2.80	3.04	0.110	0.120		
E	2.10	2.64	0.083	0.104		
E <sub>1</sub>	1.20	1.40	0.047	0.055		
е	0.95	0.95 BSC		0.0374 Ref		
e <sub>1</sub>	1.90 BSC		0.0748 Ref			
L	0.40	0.60	0.016	0.024		
L <sub>1</sub>	0.64 Ref		0.025 Ref			
S	0.50 Ref		0.020 Ref			
q	3°	8°	3°	8°		



#### **RECOMMENDED MINIMUM PADS FOR SOT-23**



Recommended Minimum Pads Dimensions in Inches/(mm)



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